

RefMat No


Included in
COMAR Database:
Green 1 --> YES
Blue 0 --> NO

 Category 1

 Category 2

 Category 3

 Category 4

 Category 5

 Type_of_RefMat:

 Name of RM: **NMIJ CRM 5204-a**

 Description **Ultrathin Silicon dioxide film: 3.49 nm (0.19 nm);
control the precision of analysis and to regulate measurement condition in depth profile analysis by ion sputtering**

 Link http://www.nmij.jp/english/service/C/crm/2_E.pdf

Certified Quantities

Film Thickness	MeanValue	3,49 nm	Uncertainty	0,2 nm
	MeanValue		nm	Uncertainty
	MeanValue		nm	Uncertainty
	MeanValue		nm	Uncertainty
	MeanValue		nm	Uncertainty

 Calibration of

 Calibration of

 Calibration of

 Calibration of

 Calibration of

 Characterised by

 Characterised by

 Characterised by

 Characterised by

 Characterised by

2 Provider

Provider No

 Provider No Web address

 Provider **NMIJ (National Metrology Institute of Japan); AIST Tsukuba Central 5**

 Contact Person Country

 Email City

 Phone City Code

 Street + No